

SANYO Semiconductors DATA SHEET

CMOSIC LC87F1HC4A — 128K-byte FROM and 12288-byte RAM integrated

8-bit 1-chip Microcontroller with USB-host controller

Overview

The LC87F1HC4A is an 8-bit microcomputer that, centered around a CPU running at a minimum bus cycle time of 83.3ns, integrates on a single chip a number of hardware features such as 128K-byte flash ROM (onboard programmable), 12288-byte RAM, an on-chip debugger, a sophisticated 16-bit timer/counter (may be divided into 8-bit timers), a 16-bit timer (may be divided into 8-bit timers or PWMs), four 8-bit timers with a prescaler, a base timer serving as a time-of-day clock, 3 channels of synchronous SIO interface with automatic data transfer capabilities, an asynchronous/synchronous SIO interface, a UART interface (full duplex), a full-speed USB interface (host control function), an 8-bit 12-channel AD converter, 2 channels of 12-bit PWM, a system clock frequency divider, an infrared remote control receiver circuit, and a 40-source 10-vector interrupt feature.

Features

- ■Flash ROM
 - Capable of on-board programming with a wide range of supply voltages: 3.0 to 5.5V
 - Block-erasable in 128 byte units
 - Writes data in 2-byte units
 - 131072×8 bits

■RAM

- 12288×9 bits
- ■Bus Cycle Time
 - 83.3ns (When CF=12MHz)

Note: The bus cycle time here refers to the ROM read speed.

- * This product is licensed from Silicon Storage Technology, Inc. (USA), and manufactured and sold by SANYO Semiconductor Co., Ltd.
- Any and all SANYO Semiconductor Co.,Ltd. products described or contained herein are, with regard to "standard application", intended for the use as general electronics equipment (home appliances, AV equipment, communication device, office equipment, industrial equipment etc.). The products mentioned herein shall not be intended for use for any "special application" (medical equipment whose purpose is to sustain life, aerospace instrument, nuclear control device, burning appliances, transportation machine, traffic signal system, safety equipment etc.) that shall require extremely high level of reliability and can directly threaten human lives in case of failure or malfunction of the product or may cause harm to human bodies, nor shall they grant any guarantee thereof. If you should intend to use our products for applications outside the standard applications of our customer who is considering such use and/or outside the scope of our intended standard applications, please consult with us prior to the intended use. If there is no consultation or inquiry before the intended use, our customer shall be solely responsible for the use.
- Specifications of any and all SANYO Semiconductor Co.,Ltd. products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.

SANYO Semiconductor Co., Ltd.

www.semiconductor-sanyo.com/network

- ■Minimum Instruction Cycle Time (tCYC)
 - 250ns (When CF=12MHz)

■Ports

• I/O ports

Ports whose I/O direction can be designated in 1-bit units 28 (P10 to P17, P20 to P27, P30 to P34,

P70 to P73, PWM0, PWM1, XT2)

Ports whose I/O direction can be designated in 4-bit units 8 (P00 to P07)

• USB ports 2 (UHD+, UHD-)

Dedicated oscillator ports
 Input-only port (also used for oscillation)
 Reset pins
 (KT1)
 (RES)

• Power supply pins 6 (VSS1 to 3, VDD1 to 3)

■Timers

• Timer 0: 16-bit timer/counter with 2 capture registers.

Mode 0: 8-bit timer with an 8-bit programmable prescaler (with two 8-bit capture registers) \times 2 channels

Mode 1: 8-bit timer with an 8-bit programmable prescaler (with two 8-bit capture registers)

+ 8-bit counter (with two 8-bit capture registers)

Mode 2: 16-bit timer with an 8-bit programmable prescaler (with two 16-bit capture registers)

Mode 3: 16-bit counter (with two 16-bit capture registers)

• Timer 1: 16-bit timer/counter that supports PWM/toggle outputs

Mode 0: 8-bit timer with an 8-bit prescaler (with toggle outputs) + 8-bit timer/

counter with an 8-bit prescaler (with toggle outputs)

Mode 1: 8-bit PWM with an 8-bit prescaler × 2 channels

Mode 2: 16-bit timer/counter with an 8-bit prescaler (with toggle outputs)

(toggle outputs also possible from lower-order 8 bits)

Mode 3: 16-bit timer with an 8-bit prescaler (with toggle outputs)

(lower-order 8 bits may be used as a PWM output)

- Timer 4: 8-bit timer with a 6-bit prescaler
- Timer 5: 8-bit timer with a 6-bit prescaler
- Timer 6: 8-bit timer with a 6-bit prescaler (with toggle outputs)
- Timer 7: 8-bit timer with a 6-bit prescaler (with toggle outputs)
- Base timer
 - 1) The clock is selectable from the subclock (32.768kHz crystal oscillation), system clock, and timer 0 prescaler output.
 - 2) Interrupts programmable in 5 different time schemes

■SIO

- SIO0: Synchronous serial interface
 - 1) LSB first/MSB first mode selectable
 - 2) Transfer clock cycle: 4/3 to 512/3 tCYC
 - 3) Automatic continuous data transmission (1 to 256 bits, specifiable in 1-bit units) (Suspension and resumption of data transmission possible in 1 byte units)
- SIO1: 8-bit asynchronous/synchronous serial interface
 - Mode 0: Synchronous 8-bit serial I/O (2- or 3-wire configuration, 2 to 512 tCYC transfer clocks)
 - Mode 1: Asynchronous serial I/O (half-duplex, 8 data bits, 1 stop bit, 8 to 2048 tCYC baudrates)
 - Mode 2: Bus mode 1 (start bit, 8 data bits, 2 to 512 tCYC transfer clocks)
 - Mode 3: Bus mode 2 (start detect, 8 data bits, stop detect)
- SIO4: Synchronous serial interface
 - 1) LSB first/MSB first mode selectable
 - 2) Transfer clock cycle: 4/3 to 1020/3 tCYC
 - 3) Automatic continuous data transmission (1 to 4096 bytes, specifiable in 1 byte units) (Suspension and resumption of data transmission possible in 1 byte units or in word units)
 - 4) Auto-start-on-falling-edge function
 - 5) Clock polarity selectable
 - 6) CRC16 calculator circuit built in

Continued on next page.

Continued from preceding page.

- SIO9: Synchronous serial interface
 - 1) LSB first/MSB first mode selectable
 - 2) Transfer clock cycle: 4/3 to 1020/3 tCYC
 - 3) Automatic continuous data transmission (1 to 4096 bytes, specifiable in 1 byte units) (Suspension and resumption of data transmission possible in 1 byte units or word units)
 - 4) Auto-start-on-falling-edge function
 - 5) Clock polarity selectable
 - 6) CRC16 calculator circuit built in

■Full Duplex UART

1) Data length: 7/8/9 bits selectable

2) Stop bits: 1 bit (2 bits in continuous transmission mode)

3) Baud rate: 16/3 to 8192/3 tCYC

■AD Converter: 8 bits × 12 channels

■PWM: Multifrequency 12-bit PWM × 2 channels

■Infrared Remote Control Receiver Circuit

- 1) Noise rejection function (noise filter time constant: Approx. 120µs when the 32.768kHz crystal oscillator is selected as the base clock)
- 2) Supports data encoding systems such as PPM (Pulse Position Modulation) and Manchester encoding.
- 3) X'tal HOLD mode reset function

■USB Interface (host control function)

- 1) Compliant with full-speed (12M bps) specifications
- 2) Supports 4 transfer types (control transfer, bulk transfer, interrupt transfer, and isochronous transfer).

■Audio Interface

1) Sampling frequency (fs): 32kHz, 44.1kHz, 48kHz

2) Master clock frequency (internal PLL): 12.288MHz, 16.9344MHz, 18.432MHz

3) Bit clock selectable: 48fs/64fs 4) Data bit length: 16/18/20/24 bits

5) LSB first/MSB firsts selectable

6) Left-justification/right-justification selectable

■Watchdog Timer

- Watchdog timer using external RC circuitry
- Interrupt and reset signals selectable

■Clock Output Function

- 1) Can output a clock with a clock rate of 1/1, 1/2, 1/4, 1/8, 1/16, 1/32, or 1/64 of the source oscillator clock selected as the system clock.
- 2) Can output the source oscillation clock for the subclock.

■Interrupts

- 40 sources, 10 vector addresses
 - 1) Provides three levels (low (L), high (H), and highest (X)) of multiplex interrupt control. Any interrupt requests of the level equal to or lower than the current interrupt are not accepted.
- 2) When interrupt requests to two or more vector addresses occur at the same time, the interrupt of the highest level takes precedence over the other interrupts. For interrupts of the same level, the interrupt into the smallest vector address takes precedence.

No.	Vector Address	Level	Interrupt Source
1	00003H	X or L	INT0
2	0000BH	X or L	INT1
3	00013H	H or L	INT2/T0L/INT4/UHC bus active/remote control signal receive
4	0001BH	H or L	INT3/INT5/base timer
5	00023H	H or L	T0H/INT6/UHC device connected/UHC disconnected/UHC resume
6	0002BH	H or L	T1L/T1H/INT7/SIO9/AIF start
7	00033H	H or L	SIO0/UART1 receive
8	0003BH	H or L	SIO1/SIO4/UART1 transmit/end of AIF
9	00043H	H or L	ADC/T6/T7/UHC-ACK/UHC-NAK/UHC error/UHC STALL
10	0004BH	H or L	Port 0/PWM0/PWM1/T4/T5/UHC-SOF/DMCOPY

- Priority levels X > H > L
- Of interrupts of the same level, the one with the smallest vector address takes precedence.
- ■Subroutine Stack Levels: 6144 levels maximum (The stack is allocated in RAM.)
- High-speed Multiplication/Division Instructions

16 bits × 8 bits
24 bits × 16 bits
16 bits ÷ 8 bits
24 bits ÷ 16 bits
(5 tCYC execution time)
(12 tCYC execution time)
(8 tCYC execution time)
(12 tCYC execution time)

■Oscillation and PLL Circuits

RC oscillation circuit (internal): For system clock
CF oscillation circuit: For system clock

• Crystal oscillation circuit: For system clock, time-of-day clock

• PLL circuit (internal): For USB interface (see Fig. 5)), audio interface (see Fig. 6)

■Standby Function

- HALT mode: Halts instruction execution while allowing the peripheral circuits to continue operation.
 - 1) Oscillation is not halted automatically.
 - 2) Canceled by a system reset or occurrence of an interrupt.
- HOLD mode: Suspends instruction execution and the operation of the peripheral circuits.
 - 1) The PLL base clock generator, CF, RC and crystal oscillators automatically stop operation.
 - 2) There are four ways of resetting the HOLD mode.
 - (1) Setting the reset pin to the lower level.
 - (2) Setting at least one of the INT0, INT1, INT2, INT4, and INT5 pins to the specified level
 - (3) Having an interrupt source established at port 0
 - (4) Having an bus active interrupt source established in the USB host controll circuit
- X'tal HOLD mode: Suspends instruction execution and the operation of the peripheral circuits except the base timer.
 - 1) The PLL base clock generator, CF and RC oscillator automatically stop operation.
 - 2) The state of crystal oscillation established when the X'tal HOLD mode is entered is retained.
 - 3) There are six ways of resetting the X'tal HOLD mode.
 - (1) Setting the reset pin to the low level
 - (2) Setting at least one of the INT0, INT1, INT2, INT4, and INT5 pins to the specified level
 - (3) Having an interrupt source established at port 0
 - (4) Having an interrupt source established in the base timer circuit
 - (5) Having an bus active interrupt source established in the USB host controll circuit
 - (6) Having an interrupt source established in the infrared remote controller receiver circuit

■Package Form

• SQFP48(7×7): Lead-free type

■Development Tools

• On-chip debugger: TCB87- type-B + LC87F1HC4A

■Flash ROM Programming Boards

Package	Programming boards
SQFP48(7 × 7)	W87F55256SQ

■Recommended EPROM Programmer

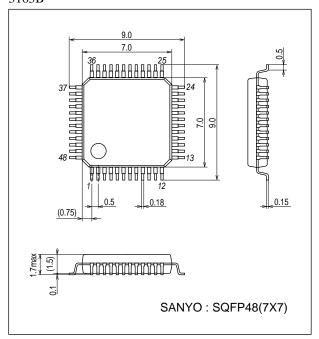
Maker		Model	Supported version	Device
Flash Support Group, Inc. (FSG)	Single Programmer	AF9708/ AF9709/AF9709B/AF9709C (Including Ando Electric Co., Ltd. models)	Rev 02.82 or later	LC87F1HC8A
Flash Support Group, Inc. (FSG) + SANYO(Note 1)	Onboard Single/Gang Programmer	AF9101/AF9103(Main body) (FSG models) SIB87(Inter Face Driver) (SANYO model)	(Note 2)	LC87F1HC8A
SANYO	Single/Gang Programmer Onboard Single/Gang Programmer	SKK/SKK TypeB (SANYO FWS) SKK-DBG TypeB (SANYO FWS)	Application Version 2.04 or later Chip Data Version 2.11 or later	LC87F1HC8

- Note 1: With the FSG onboard programmer (AF9101/AF9103) and the serial interface driver (SIB87) provided by SANYO, PC-less standalone onboard programming is possible
- Note 2: Depending on programming conditions, it is necessary to use a dedicated programming device and a program. Please contact SANYO or FSG if you have any questions or difficulties regarding this matter.

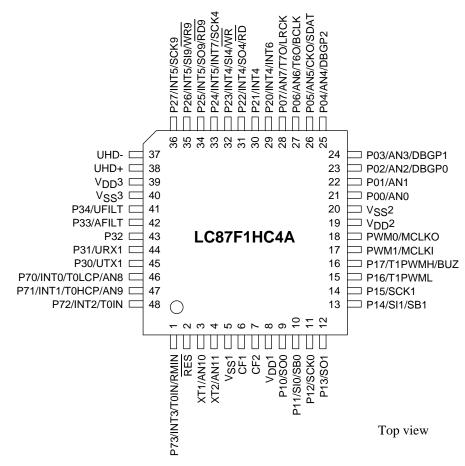
Package Dimensions

unit: mm (typ)

3163B



Pin Assignment

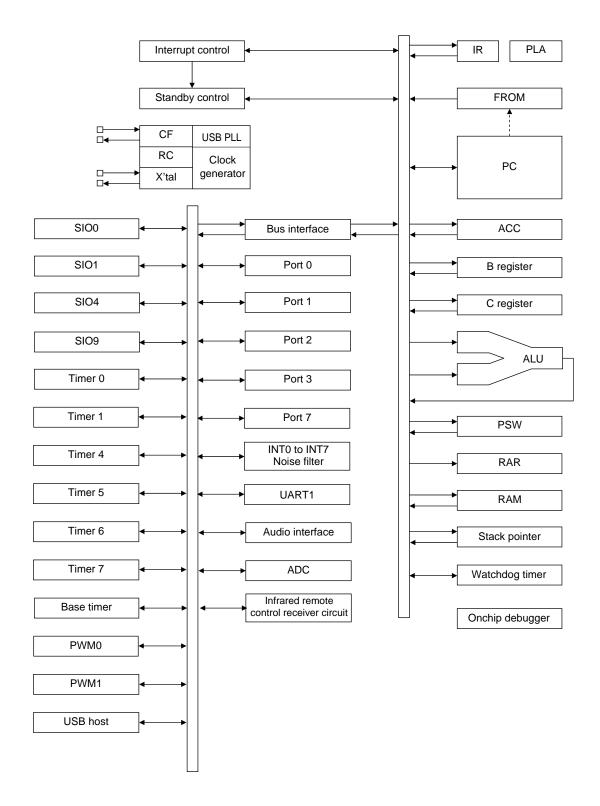


SANYO: SQFP48(7×7) "Lead-free Type"

SQFP48	NAME
1	P73/INT3/T0IN/RMIN
2	RES
3	XT1/AN10
4	XT2/AN11
5	V _{SS} 1
6	CF1
7	CF2
8	V _{DD} 1
9	P10/SO0
10	P11/SI0/SB0
11	P12/SCK0
12	P13/SO1
13	P14/SI1/SB1
14	P15/SCK1
15	P16/T1PWML
16	P17/T1PWMH/BUZ
17	PWM1/MCLKI
18	PWM0/MCLKO
19	V_{DD}^2
20	V _{SS} 2
21	P00/AN0
22	P01/AN1
23	P02/AN2/DBGP0
24	P03/AN3/DBGP1

SQFP48	NAME
25	P04/AN4/DBGP2
26	P05/AN5/CKO/SDAT
27	P06/AN6/T6O/BCLK
28	P07/AN7/T7O/LRCK
29	P20/INT4/INT6
30	P21/INT4
31	P22/INT4/SO4/RD
32	P23/INT4/SI4/WR
33	P24/INT5/INT7/SCK4
34	P25/INT5/SO9/RD9
35	P26/INT5/SI9/WR9
36	P27/INT5/SCK9
37	UHD-
38	UHD+
39	V _{DD} 3
40	V _{SS} 3
41	P34/UFILT
42	P33/AFILT
43	P32
44	P31/URX1
45	P30/UTX1
46	P70/INT0/T0LCP/AN8
47	P71/INT1/T0HCP/AN9
48	P72/INT2/T0IN

System Block Diagram



Pin Description

Pin Name	I/O			De	scription			Option	
V _{SS} 1,V _{SS} 2,	-	- power supply						No	
V_{SS}^3									
V _{DD} 1, V _{DD} 2	-	+ power supply						No	
V _{DD} 3	-	USB reference	voltage					Yes	
Port 0	I/O	8-bit I/O ports	·						
P00 to P07		I/O specifiable							
		*		d on and off in 4	l-bit units.				
		HOLD reset in	•						
		Port 0 interrupPin functions	ot input						
			input ports: AN0) to AN7(P00 to	P07)				
				0 to DBGP2(P0	•				
		P05: System of	clock output/aud	lio interface SD/	AT input/output				
		P06: Timer 6 t	toggle output/au	idio interface BC	LK input/output				
		P07: Timer 7 t	toggle output/au	idio interface LR	CK input/output				
Port 1	I/O	8-bit I/O ports						Yes	
P10 to P17		I/O specifiable							
		*	ors can be turne	d on and off in 1	-bit units.				
		 Pin functions P10: SIO0 dat 	a outout	P1.	4: SIO1 data inpu	ıt/bus innut/outn	ut		
			ta input/bus inpu		5: SIO1 clock inp		ut		
			ck input/output	•	6: Timer 1 PWML	•			
		P13: SIO1 dat		P1	7: Timer 1 PWMI	d output/beeper	output		
Port 2	I/O	8-bit I/O ports						Yes	
P20 to P27		I/O specifiable	in 1-bit units						
			ors can be turne	d on and off in 1	-bit units.				
			 Pin functions P20 to P23: INT4 input/HOLD reset input/timer 1 event input/timer 0L capture input/ 						
				· ·	er 1 event input/til	mer oL capture i	nput/		
			mer 0H capture	•	er 1 event input/ti	mer 01 capture i	nnut/		
			mer 0H capture	-	i i ovom mpaga	mor or captaro	iipat		
			ut/timer 0L capt	•					
		P22: SIO4 dat	P22: SIO4 data input/output/parallel interface RD output						
		P23: SIO4 data input/output/parallel interface WR output							
		P24: SIO4 clo							
				arallel interface					
				arallel interface	WK9 output				
			ck input/output owledge types						
		interrupt don.	Rising	Falling	Rising & Falling	H level	L level		
		INT4	enable	enable	enable	disable	disable		
		INT5	enable	enable	enable	disable	disable		
		INT6	enable	enable	enable	disable	disable		
		INT7	enable	enable	enable	disable	disable		
Port 3	I/O	• 5-bit I/O ports						Yes	
P30 to P34		I/O specifiable	in 1-bit units						
		Pull-up resistor	ors can be turne	d on and off in 1	-bit units.				
		Pin functions							
		P30: UART1 t							
		P31: UART1 r		r pin (see Fig. 6.	١				
				pin (see Fig. 6. pin (see Fig. 5.))				

Continued on next page.

Continued from preceding page.

Pin Name	I/O			Des	cription			Option	
Port 7	I/O	• 4-bit I/O port	4-bit I/O port						
P70 to P73		I/O specifiable in the second se	n 1-bit units						
		Pull-up resistor	s can be turned	on and off in 1-	bit units.				
		 Pin functions 							
		P70: INT0 input	/HOLD reset inp	out/timer 0L cap	ture input/watch	dog timer output			
		P71: INT1 input		•	•				
		•			t input/timer 0L o	capture input/			
			d clock counter i	-					
			` '	,	event input/timer	0H capture inpu	ut/		
			controller receiv	•					
		AD converter in		P70), AN9(P71)					
		Interrupt acknow	wieage types		Dising 0				
			Rising	Falling	Rising & Falling	H level	L level		
		INT0	enable	enable	disable	enable	enable		
		INT1	enable	enable	disable	enable	enable		
		INT2	enable	enable	enable	disable	disable		
		INT3	enable	enable	enable	disable	disable		
PWM0	I/O	PWM0, PWM1 o	utput port					No	
PWM1		General-purpose input port							
		Pin functions							
		PWM0: Audio interface master clock output							
		PWM1: Audio in	nterface master	clock input					
UHD-	I/O	USB data I/O pin	UHD-/general-p	ourpose I/O port				No	
UHD+	I/O	USB data I/O pin	UHD+/general-	purpose I/O por	t			No	
RES	Input	Reset pin						No	
XT1	Input	• 32.768kHz crys	tal oscillator inp	ut				No	
		Pin functions							
		General-purpos							
		AD converter in							
		Must be connec			ed.				
XT2	I/O	• 32.768kHz crys	tal oscillator out	put				No	
		Pin functions							
	1	General-purpos							
	1	AD converter in							
CF1	Innut	Must be set for		ept open if not	to be used.				
	Input	Ceramic/crystal r	•					No	
CF2	Output	Ceramic/crystal r	esonator output					No	

Port Output Types

The table below lists the types of port outputs and the presence/absence of a pull-up resistor.

Data can be read into any input port even if it is in the output mode.

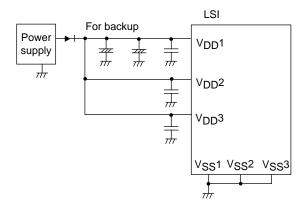
Port Name	Option selected in units of	Option type	Output type	Pull-up resistor
P00 to P07	1 bit	1	CMOS	Programmable (Note 1)
		2	Nch-open drain	No
P10 to P17	1 bit	1	CMOS	Programmable
P20 to P27 P30 to P34		2	Nch-open drain	Programmable
P70	-	No	Nch-open drain	Programmable
P71 to P73	-	No	CMOS	Programmable
PWM0, PWM1	-	No	CMOS	No
UHD+, UHD-	-	No	CMOS	No
XT1	-	No	Input only	No
XT2	-	No	32.768kHz crystal resonator output (N channel open drain when in general-purpose output mode)	No

Note 1: Programmable pull-up resistors for port 0 are controlled in 4 bit units (P00 to 03, P04 to 07).

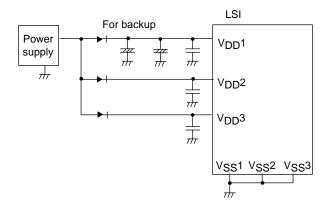
Power Pin Treatment

Connect the IC as shown below to minimize the noise input to the V_{DD1} pin. and extend the backup period. Be sure to electrically short the V_{SS1} , V_{SS2} , and V_{SS3} pins.

Example 1: When the microcontroller is in the backup state in the HOLD mode, the power to sustain the high level of output ports is supplied by their backup capacitors.



Example 2: The high level output at ports is not sustained and unstable in the HOLD backup mode.



USB Reference Power Option

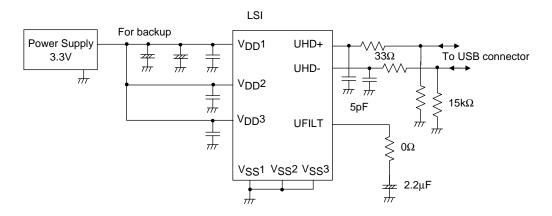
When a voltage 4.5 to 5.5V is supplied to V_{DD}1 and the internal USB reference voltage circuit is activated, the reference voltage for USB port output is generated. The active/inactive state of the reference voltage circuit can be switched by option select. The procedure for marking the option selection is described below.

		(1)	(2)	(3)	(4)
Option settings	USB regulator	USE	USE	USE	NONUSE
	USB regulator at HOLD mode	USE	NONUSE	NONUSE	NONUSE
	USB regulator at HALT mode	USE	NONUSE	USE	NONUSE
Reference voltage circuit state	Normal mode	active	active	active	inactive
	HOLD mode	active	inactive	inactive	inactive
	HALT mode	active	inactive	active	inactive

- When the USB reference voltage circuit is made inactive, the level of the reference voltage for USB port output is equal to V_{DD}1.
- Selection (2) or (3) can be used to set the reference voltage circuit inactive in HOLD or HALT mode.
- When the reference voltage circuit is activated, the current drain increases by approximately 100µA compared with when the reference voltage circuit is inactive.

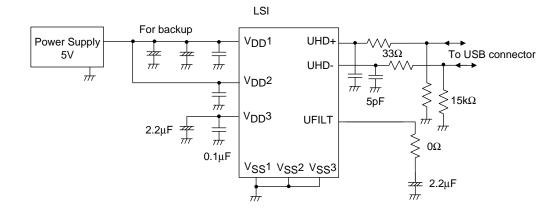
Example 1: $V_{DD}1=V_{DD}2=3.3V$

- Inactivating the reference voltage circuit (selection (4)).
- Connecting V_{DD}3 to V_{DD}1 and V_{DD}2.



Example 2: VDD1=VDD2=5.0V

- Activating the reference voltage circuit (selection (1)).
- Isolating VDD3 from VDD1 and VDD2, and connecting capacitor between VDD3 and VSS.



Absolute Maximum Ratings at Ta = 25°C, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

	Parameter	Symbol	Pin/Remarks	Constitution of			Specifi	cation	
		-	1 III/IXeIIIaiks	Conditions	\/ F\/1		4		!4
	imum supply	V _{DD} max	V _{DD} 1, V _{DD} 2, V _{DD} 3	V _{DD} 1= V _{DD} 2= V _{DD} 3	V _{DD} [V]	min -0.3	typ	max +6.5	unit
volta	ige it voltage	V _I (1)	XT1, CF1			-0.3		\/== 10.3	
	t/output	V _{IO} (1)	Ports 0, 1, 2, 3, 7			-0.3		V _{DD} +0.3	V
volta	•	10()	PWM0, PWM1 XT2			-0.3		V _{DD} +0.3	
	Peak output	IOPH(1)	Ports 0, 1, 2	When CMOS output					
	current			type is selected		-10			
		IODIT(0)	DIAMAG DIAMAA	Per 1 applicable pin					
		IOPH(2)	PWM0, PWM1	Per 1 applicable pin		-20			
		IOPH(3)	Port 3 P71 to P73	When CMOS output type is selected		-5			
			17110173	Per 1 applicable pin		-5			
	Average	IOMH(1)	Ports 0, 1, 2	When CMOS output					
Ħ	output current			type is selected		-7.5			
High level output current	(Note 1-1)			Per 1 applicable pin					
ont c		IOMH(2)	PWM0, PWM1	Per 1 applicable pin		-15			
outp		IOMH(3)	Port 3	When CMOS output					
vel			P71 to P73	type is selected		-3			
Jy le	Tatal autaut	EIOVII(4)	Darta O. O.	Per 1 applicable pin Tatal assessed of all					
_	Total output current	ΣΙΟΑH(1)	Ports 0, 2	Total current of all applicable pins		-25			
	current	ΣΙΟΑΗ(2)	Port 1	Total current of all					
			PWM0, PWM1	applicable pins		-25			
		ΣΙΟΑΗ(3)	Ports 0, 1, 2	Total current of all		45			
			PWM0, PWM1	applicable pins		-45			
		ΣIOAH(4)	Port 3	Total current of all		-10			
			P71 to P73	applicable pins					
		ΣIOAH(5)	UHD+, UHD-	Total current of all		-25			mA
+	Peak output	IOPL(1)	P02 to P07	applicable pins Per 1 applicable pin					
	current	101 L(1)	Ports 1, 2	i ei i applicable pili				20	
			PWM0, PWM1						
		IOPL(2)	P00, P01	Per 1 applicable pin				30	
		IOPL(3)	Ports 3, 7	Per 1 applicable pin				10	
L			XT2					10	
	Average	IOML(1)	P02 to P07	Per 1 applicable pin					
aut	output current		Ports 1, 2					15	
curre	(Note 1-1)	IOML(2)	PWM0, PWM1 P00, P01	Per 1 applicable pin				20	
but		IOML(3)	Ports 3, 7					20	
ont		IONIL(3)	XT2	Per 1 applicable pin				7.5	
>	Total output current	ΣIOAL(1)	Ports 0, 2	Total current of all applicable pins				45	
۲		ΣIOAL(2)	Port 1	Total current of all					
		- ()	PWM0, PWM1	applicable pins				45	
		ΣIOAL(3)	Ports 0, 1, 2 PWM0, PWM1	Total current of all				80	
		ΣIOAL(4)	Ports 3, 7	applicable pins Total current of all					
		ZIOAL(4)	XT2	applicable pins				15	
		ΣIOAL(5)	UHD+, UHD-	Total current of all					
		. ,	·	applicable pins				25	
	wable power	Pd max	SQFP48(7×7)	Ta=-40 to +85°C				140	mW
Ope	rating ambient perature	Topr				-40		+85	
	age ambient perature	Tstg				-55		+125	°C

Note 1-1: The average output current is an average of current values measured over 100 ms intervals.

Allowable Operating Conditions at Ta = -40 °C to +85 °C, $V_SS1 = V_SS2 = V_SS3 = 0V$

	0 1 1	D' / D	0 - 10			Specific	ation	
Parameter	Symbol	Pin/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Operating	V _{DD} (1)	$V_{DD}1=V_{DD}2=V_{DD}3$	0.245μs ≤ tCYC ≤ 200μs		3.0		5.5	
supply voltage (Note 2-1)			0.490µs ≤ tCYC ≤ 200µs Except in onboard programming mode		2.7		5.5	
Memory sustaining supply voltage	VHD	V _{DD} 1=V _{DD} 2=V _{DD} 3	RAM and register contents sustained in HOLD mode.		2.0		5.5	
High level input voltage	V _{IH} (1)	Port 0, 1, 2, 3 P71 to P73 P70 port input/ interrupt side PWM0, PWM1		2.7 to 5.5	0.3V _{DD} +0.7		V _{DD}	
	V _{IH} (2)	Port 70 watchdog timer side		2.7 to 5.5	0.9V _{DD}		V _{DD}	.,
	V _{IH} (3)	XT1, XT2, CF1, RES		2.7 to 5.5	0.75V _{DD}		V_{DD}	V
Low level input voltage	V _{IL} (1)	Port 1, 2, 3 P71 to P73		4.0 to 5.5	V _{SS}		0.1V _{DD} +0.4	
	V _{IL} (2)	P70 port input/ interrupt side		2.7 to 4.0	V _{SS}		0.2V _{DD}	
	V _{IL} (3)	Port 0 PWM0, PWM1		4.0 to 5.5	V _{SS}		0.15V _{DD} +0.4	
	V _{IL} (4)			2.7 to 4.0	V _{SS}		0.2V _{DD}	
	V _{IL} (5)	Port 70 watchdog timer side		2.7 to 5.5	V _{SS}		0.8V _{DD} -1.0	
	V _{IL} (6)	XT1, XT2, CF1, RES		2.7 to 5.5	V _{SS}		0.25V _{DD}	
Instruction	tCYC			3.0 to 5.5	0.245		200	
cycle time (Note 2-2)			Except for onboard programming mode	2.7 to 5.5	0.490		200	μs
External system clock frequency	FEXCF(1)	CF1	CF2 pin open System clock frequency division ratio=1/1 External system clock duty =50±5%	3.0 to 5.5	0.1		12	
			CF2 pin open System clock frequency division ratio=1/1 External system clock duty =50±5%	2.7 to 5.5	0.1		6	MHz
Oscillation frequency	FmCF(1)	CF1, CF2	When 12MHz ceramic oscillation See Fig. 1.	3.0 to 5.5		12		
range (Note 2-3)	FmCF(2)	CF1, CF2	When 6MHz ceramic oscillation See Fig. 1.	2.7 to 5.5		6		MHz
·	FmRC		Internal RC oscillation	2.7 to 5.5	0.3	1.0	2.0	
	FsX'tal	XT1, XT2	32.768kHz crystal oscillation See Fig. 2.	2.7 to 5.5		32.768		kHz

Note 2-1: V_{DD} must be held greater than or equal to 3.0V in the flash ROM onboard programming mode.

Note 2-3: See Tables 1 and 2 for the oscillation constants.

Note 2-2: Relationship between tCYC and oscillation frequency is 3/FmCF at a division ratio of 1/1 and 6/FmCF at a division ratio of 1/2.

Electrical Characteristics at $Ta = -40^{\circ}C$ to $+85^{\circ}C$, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

Parameter	Symbol	Pin/Remarks	Conditions			Specifica	ation	
Farameter	Symbol	Fill/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
High level input current	I _{IH} (1)	Ports 0, 1, 2, 3 Port 7 RES PWM0, PWM1 UHD+, UHD-	Output disabled Pull-up resistor off VIN=VDD (Including output Tr's off leakage current)	2.7 to 5.5			1	
	I _{IH} (2)	XT1, XT2	Input port configuration VIN=VDD	2.7 to 5.5			1	
	I _{IH} (3)	CF1	V _{IN} =V _{DD}	2.7 to 5.5			15	μА
Low level input current	I _{IL} (1)	Ports 0, 1, 2, 3 Port 7 RES PWM0, PWM1 UHD+, UHD-	Output disabled Pull-up resistor off VIN=VSS (Including output Tr's off leakage current)	2.7 to 5.5	-1			μΑ
	I _{IL} (2)	XT1, XT2	Input port configuration VIN=VSS	2.7 to 5.5	-1			
	I _{IL} (3)	CF1	V _{IN} =V _{SS}	2.7 to 5.5	-15			
High level output	V _{OH} (1)	Ports 0, 1, 2, 3 P71 to P73	I _{OH} =-1mA	4.5 to 5.5	V _{DD} -1			
voltage	V _{OH} (2)		I _{OH} =-0.4mA	3.0 to 5.5	V _{DD} -0.4			
	V _{OH} (3)		I _{OH} =-0.2mA	2.7 to 5.5	V _{DD} -0.4			
	V _{OH} (4)	PWM0, WM1	I _{OH} =-10mA	4.5 to 5.5	V _{DD} -1.5			
	V _{OH} (5)	P05 to P07	I _{OH} =-1.6mA	3.0 to 5.5	V _{DD} -0.4			
	V _{OH} (6)	(Note 3-1)	I _{OH} =-1mA	2.7 to 5.5	V _{DD} -0.4			
Low level output	V _{OL} (1)	P00, P01	I _{OL} =30mA	4.5 to 5.5			1.5	V
voltage	V _{OL} (2)		I _{OL} =5mA	3.0 to 5.5			0.4	v
	V _{OL} (3)		I _{OL} =2.5mA	2.7 to 5.5			0.4	
	V _{OL} (4)	Ports 0, 1, 2	I _{OL} =10mA	4.5 to 5.5			1.5	
	V _{OL} (5)	PWM0, PWM1	I _{OL} =1.6mA	3.0 to 5.5			0.4	
	V _{OL} (6)	XT2	I _{OL} =1mA	2.7 to 5.5			0.4	
	V _{OL} (7)	Ports 3, 7	I _{OL} =1.6mA	3.0 to 5.5			0.4	
	V _{OL} (8)		I _{OL} =1mA	2.7 to 5.5			0.4	
Pull-up resistance	Rpu(1)	Ports 0, 1, 2, 3	V _{OH} =0.9V _{DD}	4.5 to 5.5	15	35	80	kΩ
	Rpu(2)	Port 7		2.7 to 5.5	18	50	150	KS2
Hysteresis voltage	VHYS	RES Port 1, 2, 3, 7		2.7 to 5.5		0.1V _{DD}		V
Pin capacitance	СР	All pins	For pins other than that under test: VIN=VSS f=1MHz Ta=25°C	2.7 to 5.5		10		pF

Note 3-1: When the CKO system clock output function (P05) or audio interface output function (P05 to P07) is used.

Serial I/O Characteristics at Ta = -40°C to +85°C, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

1. SIO0 Serial I/O Characteristics (Note 4-1-1)

	-) aramatar	Cumbal	Pin/	Conditions			Spec	ification	
	,	Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(1)	SCK0(P12)	See Fig. 8.		2			
		Low level pulse width	tSCKL(1)				1			
		High level pulse width	tSCKH(1)				1			
	clock		tSCKHA(1a)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY not used at the same time. See Fig. 8. (Note 4-1-2)		4			
	Input clock		tSCKHA(1b)		Continuous data transfer mode USB used at the same time. AIF, SIO4, SIO9, and DMCOPY not used at the same time. See Fig. 8. (Note 4-1-2)	2.7 to 5.5	7			tCYC
S S			tSCKHA(1c)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY used at the same time. See Fig. 8. (Note 4-1-2)		9			
Serial clock		Frequency	tSCK(2)	SCK0(P12)	When CMOS output type is selected		4/3			
S		Low level pulse width	tSCKL(2)		• See Fig. 8.			1/2	•	
		High level pulse width	tSCKH(2)					1/2		tSCK
	clock	pulce mau.	tSCKHA(2a)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY not used at the same time. When CMOS output type is selected See Fig. 8.		tSCKH(2) +2tCYC		tSCKH(2) + (10/3)tCYC	
	Output clock		tSCKHA(2b)		Continuous data transfer mode USB used at the same time. AIF, SIO4, SIO9, and DMCOPY not used at the same time. When CMOS output type is selected. See Fig. 8.	2.7 to 5.5	tSCKH(2) +2tCYC		tSCKH(2) + (19/3)tCYC	tCYC
			tSCKHA(2c)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY used at the same time When CMOS output type is selected See Fig. 8.		tSCKH(2) +2tCYC		tSCKH(2) + (25/3)tCYC	

Note 4-1-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.

Note 4-1-2: In an application where the serial clock input is to be used in the continuous data transfer mode, the time from SI0RUN being set when serial clock is high to the falling edge of the first serial clock must be longer than tSCKHA.

Continued on next page.

Continued from preceding page.

		Parameter	Symbol	Pin/	Conditions			Spec	ification	
		rarameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Serial input		ta setup time	tsDI(1)	SB0(P11), SI0(P11)	Must be specified with respect to rising edge of SIOCLK. See Fig. 8.	0.74- 5.5	0.03			
Serial	Da	ta hold time	thDI(1)			2.7 to 5.5	0.03			
	clock	Output delay time	tdD0(1)	SO0(P10), SB0(P11)	Continuous data transfer mode (Note 4-1-3)				(1/3)tCYC +0.05	μs
Serial output	Input clock		tdD0(2)		Synchronous 8-bit mode (Note 4-1-3)	2.7 to 5.5			1tCYC +0.05	
Seria	Output clock		tdD0(3)		(Note 4-1-3)				(1/3)tCYC +0.05	

Note 4-1-3: Must be specified with respect to falling edge of SIOCLK.

Must be specified as the time to the beginning of output state change in open drain output mode. See Fig. 8.

2. SIO1 Serial I/O Characteristics (Note 4-2-1)

		D	0	Pin/	Conditions			Spec	ification	
		Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
	×	Frequency	tSCK(3)	SCK1(P15)	See Fig. 8.		2			
	Input clock	Low level pulse width	tSCKL(3)			2.7 to 5.5	1			.0.40
Serial clock	lul	High level pulse width	tSCKH(3)				1			tCYC
Serial	ock	Frequency	tSCK(4)	SCK1(P15)	When CMOS output type is selected		2			
	Output clock	Low level pulse width	tSCKL(4)		• See Fig. 8.	2.7 to 5.5		1/2		tSCK
	O	High level pulse width	tSCKH(4)					1/2		ISCK
Serial input	Da	ata setup time	tsDI(2)	SB1(P14), SI1(P14)	Must be specified with respect to rising edge of SIOCLK. See Fig. 8.	0.7.	0.03			
Serial	Da	ata hold time	thDI(2)			2.7 to 5.5	0.03			
Serial output	Ou	utput delay time	tdD0(4)	SO1(P13), SB1(P14)	Must be specified with respect to falling edge of SIOCLK. Must be specified as the time to the beginning of output state change in open drain output mode. See Fig. 8.	2.7 to 5.5			(1/3)tCYC +0.05	μѕ

Note 4-2-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.

3. SIO4 Serial I/O Characteristics (Note 4-3-1)

	-	Parameter	Symbol	Pin/	Conditions			Speci	ification	
	· ·	rarameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(5)	SCK4(P24)	See Fig. 8.		2			
		Low level pulse width	tSCKL(5)				1			
		High level	tSCKH(5)				1			
		pulse width	tSCKHA(5a)		USB, SIO0 continuous transfer mode, AIF, SIO9, and DMCOPY not used at the same time. See Fig. 8. (Note 4-3-2)		4			
	Input clock		tSCKHA(5b)		USB used at the same time SIO0 continuous transfer mode, AIF, SIO9, DMCOPY not used at the same time. See Fig. 8. (Note 4-3-2)	2.7 to 5.5	7			tCYC
			tSCKHA(5c)		USB, SIO0 continuous transfer mode, SIO9, and DMCOPY used at the same time. AIF not used at the same time. See Fig. 8. (Note 4-3-2)		12			
상		Frequency	tSCK(6)	SCK4(P24)	When CMOS output type is		4/3			
Serial clock		Low level pulse width	tSCKL(6)		selected. • See Fig. 8.			1/2		
l o		High level pulse width	tSCKH(6)					1/2		tSCK
	ock	(Note 4-3-3)	tSCKHA(6a)		USB, SIO0 continuous transfer mode, AIF, SIO9, and DMCOPY not used at the same time. When CMOS output type is selected. See Fig. 8.		tSCKH(6) + (5/3)tCYC		tSCKH(6) + (10/3)tCYC	
	Output clock		tSCKHA(6b)		USB used at the same time. SIO0 continuous transfer mode, AIF, SIO9, and DMCOPY not used at the same time. When CMOS output type is selected. See Fig. 8. USB, SIO0 continuous transfer mode, SIO9, and DMCOPY used at the same time.	2.7 to 5.5	tSCKH(6) + (5/3)tCYC		tSCKH(6) + (19/3)tCYC	tCYC
					AlF not used at the same time. When CMOS output type is selected. See Fig. 8.		+ (5/3)tCYC		+ (34/3)tCYC	

- Note 4-3-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.
- Note 4-3-2: In an application where the serial clock input is to be used in the continuous data transfer mode, the period from the time SI4RUN is set with the serial clock set high to the falling edge of the first serial clock must be longer than tSCKHA.
- Note 4-3-3: When using the serial clock output, make sure that the load at the SCK4 (P24) pin meets the following conditions:
 - Clock rise time tSCKR $< 0.037\mu s$ (see Figure 12.) at Ta=+25°C, V_{DD}=3.3V

Continued on next page.

Continued from preceding page.

	Parameter	Symbol	Pin/	Conditions			Spec	ification	
	Farameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
input	Data setup time	tsDI(3)	SO4(P22), SI4(P23)	Must be specified with respect to falling edge of SIOCLK. See Fig. 8	0.7.1.5.5	0.03			
Serial	Data hold time	thDI(3)			2.7 to 5.5	0.03			
Serial output	Output delay time	tdD0(5)	SO4(P22), SI4(P23)	Must be specified with respect to rising edge of SIOCLK. Must be specified as the time to the beginning of output state change in open drain output mode. See Fig. 8.	2.7 to 5.5			(1/3)tCYC +0.05	μs

4. SIO9 Serial I/O Characteristics (Note 4-4-1)

	-	Parameter	Symbol	Pin/	Conditions			Specifi	cation	
		rarameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(7)	SCK9(P27)	See Fig. 8.		2			
		Low level pulse width	tSCKL(7)				1			
		High level pulse width	tSCKH(7)				1			
lock	ock		tSCKHA(7a)		USB, SIO0 continuous transfer mode, AIF, SIO4 and DMCOPY not used at the same time. See Fig. 8. (Note 4-4-2)		4			
Serial clock	Input clock		tSCKHA(7b)		USB used at the same time. SIO0 continuous transfer mode, AIF, SIO4, and DMCOPY not used at the same time. See Fig. 8. (Note 4-4-2)	2.7 to 5.5	7			tCYC
			tSCKHA(7c)		USB, SIO0 continuous transfer mode, SIO4 and DMCOPY used at the same time. AIF not used at the same time. See Fig. 8. (Note 4-4-2)		15			

Note 4-4-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.

Note 4-4-2: In an application where the serial clock input is to be used in the continuous data transfer mode, the period from the time SI9RUN is set with the serial clock set high to the falling edge of the first serial clock must be longer than tSCKHA.

Continued on next page

Continued from preceding page

		ed from precedin		Pin/	0 - 111			Specif	ication	
	F	Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(8)	SCK9(P27)	When CMOS output type is selected.		4/3			tCYC
		Low level pulse width	tSCKL(8)		• See Fig. 8.			1/2		40.0K
		High level pulse width	tSCKH(8)					1/2		tSCK
×	8	(Note 4-4-3)	tSCKHA(8a)		USB, SIO0 continuous transfer mode, AIF SIO4 DMCOPY not used at the same time. When CMOS output type is selected. See Fig. 8.		tSCKH(8) + (5/3)tCYC		tSCKH(8) + (10/3)tCYC	
Serial clock	Output clock		tSCKHA(8b)		USB used at the same time. SIO0 continuous transfer mode, AIF, SIO4, and DMCOPY not used at the same time. When CMOS output type is selected See Fig. 8.	2.7 to 5.5	tSCKH(8) + (5/3)tCYC		tSCKH(8) + (19/3)tCYC	tCYC
			tSCKHA(8c)		USB, SIO0 continuous transfer mode, SIO4, and DMCOPY used at the same time. AIF not used at the same time. When CMOS output type is selected. See Fig. 8.		tSCKH(8) + (5/3)tCYC		tSCKH(8) + (43/3)tCYC	
input	Da	ta setup time	tsDI(4)	SO9(P25), SI9(P26)	Must be specified with respect to rising edge of SIOCLK. See Fig. 8.		0.03			
Serial input	Da	ta hold time	thDI(4)		,	2.7 to 5.5	0.03			
Serial output	Ou	ttput delay time	tdDO(6)	SO9(P25), SI9(P26)	Must be specified with respect to falling edge of SIOCLK. Must be specified as the time to the beginning of output state change in open drain output mode See Fig. 8.	2.7 to 5.5			(1/3)tCYC +0.05	μѕ

Note 4-4-3: When using the serial clock output, make sure that the load at the SCK9 (P27) pin meets the following conditions:

Clock rise time tSCKR < 0.037 μs (see Figure 12.) at Ta=+25 $^{\circ}C,\,V_{\mbox{DD}}\!=\!3.3V$

Pulse Input Conditions at Ta = -40°C to +85°C, $V_SS1 = V_SS2 = V_SS3 = 0V$

Parameter	Cumbal	Pin/Remarks	Conditions			Speci	ification	
Parameter	Symbol	FIII/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
High/low level pulse width	tP1H(1) tP1L(1)	INT0(P70), INT1(P71), INT2(P72), INT4(P20 to P23), INT5(P24 to P27), INT6(P20), INT7(P24)	Interrupt source flag can be set. Event inputs for timer 0 or 1 are enabled.	2.7 to 5.5	1			
	tPIH(2) tPIL(2)	INT3(P73) when noise filter time constant is 1/1	Interrupt source flag can be set. Event inputs for timer 0 are enabled.	2.7 to 5.5	2			tCYC
	tPIH(3) tPIL(3)	INT3(P73) when noise filter time constant is 1/32	Interrupt source flag can be set. Event inputs for timer 0 are nabled.	2.7 to 5.5	64			
	tPIH(4) tPIL(4)	INT3(P73) when noise filter time constant is 1/128	Interrupt source flag can be set. Event inputs for timer 0 are enabled.	2.7 to 5.5	256			
	tPIL(5)	RMIN(P73)	Recognized by the infrared remote control receiver circuit as a signal	2.7 to 5.5	4			RMCK (Note 5-1)
	tPIL(6)	RES	Resetting is enabled.	2.7 to 5.5	200			μs

Note 5-1: Represents the period of the reference clock (1 tCYC to 128 tCYC or the source frequency of the subclock) for the infrared remote control receiver circuit.

AD Converter Characteristics at $Ta = -40^{\circ}C$ to $+85^{\circ}C$, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

			ut 10 0 to 100 0,	. 22 -	, 22–	່ນວ	• .	
Parameter	Cumhal	Pin/Remarks	Conditions			Specifi	cation	
Parameter	Symbol	Pin/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Resolution	N	AN0(P00) to		3.0 to 5.5		8		bit
Absolute accuracy	ET	AN7(P07), AN8(P70),	(Note 6-1)	3.0 to 5.5			±1.5	LSB
Conversion time	TCAD	AN9(P71),	AD conversion time=32×tCYC		15.68		97.92	
		AN10(XT1),	(when ADCR2=0) (Note 6-2)	4.5 to 5.5	(tCYC=		(tCYC=	
		AN11(XT2)			0.490µs)		3.06µs)	
					23.52		97.92	
				3.0 to 5.5	(tCYC=		(tCYC=	
					0.735µs)		3.06µs)	
			AD conversion time=64×tCYC		18.82		97.92	μs
			(when ADCR2=1) (Note 6-2)	4.5 to 5.5	(tCYC=		(tCYC=	
					0. 294µs)		1.53µs)	
					47.04		97.92	
				3.0 to 5.5	(tCYC=		(tCYC=	
					0.735µs)		1.53µs)	
Analog input voltage range	VAIN			3.0 to 5.5	V _{SS}		V_{DD}	V
Analog port	IAINH		VAIN=V _{DD}	3.0 to 5.5			1	
input current	IAINL		VAIN=V _{SS}	3.0 to 5.5	-1	_		μΑ

Note 6-1: The quantization error ($\pm 1/2$ LSB) is excluded from the absolute accuracy.

Note 6-2: The conversion time refers to the period from the time when an instruction for starting a conversion process is issued to the time the conversion results register(s) are loaded with a complete digital conversion value corresponding to the analog input value.

Consumption Current Characteristics at $Ta = -40^{\circ}C$ to $+85^{\circ}C$, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

		Pin/		· - 7 · D	31 ,	Specif	ication	
Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Normal mode consumption current	IDDOP(1)	V _{DD} 1 =V _{DD} 2 =V _{DD} 3	FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side	4.5 to 5.5		9.8	24	
(Note 7-1)	IDDOP(2)		Internal PLL oscillation stopped Internal RC oscillation stopped USB circuit stopped 1/1 frequency division ratio	3.0 to 3.6		5.7	14	
	IDDOP(3)		FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side	4.5 to 5.5		15	35	
	IDDOP(4)		Internal PLL oscillation mode active Internal RC oscillation stopped USB circuit active I/1 frequency division ratio	3.0 to 3.6		7.7	20	mA
	IDDOP(5)		FmCF=12MHz ceramic oscillation mode	4.5 to 5.5		6.7	16	
	IDDOP(6)	-	FsX'tal=32.768kHz crystal oscillation mode System clock set to 6MHz side	3.0 to 3.6		3.9	9.0	
	IDDOP(7)	-	Internal RC oscillation stopped 1/2 frequency division ratio	2.7 to 3.0		3.2	7.3	
	IDDOP(8)		FmCF=0Hz(oscillation stopped)	4.5 to 5.5		0.72	3.4	
	IDDOP(9)		FsX'tal=32.768kHz crystal oscillation mode	3.0 to 3.6		0.41	1.9	
	IDDOP(10)		System clock set to internal RC oscillation.1/2 frequency division ratio	2.7 to 3.0		0.35	1.5	
	IDDOP(11)		FmCF=0Hz(oscillation stopped) FsX'tal=32.768kHz crystal oscillation mode	4.5 to 5.5		45	184	
	IDDOP(12)		System clock set to crystal oscillation. (32.768kHz)	3.0 to 3.6		18	65	μΑ
	IDDOP(13)		Internal RC oscillation stopped 1/2 frequency division ratio	2.7 to 3.0		14	47	
HALT mode consumption current (Note7-1)	IDDHALT(1)		HALT mode FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side	4.5 to 5.5		4.9	12	
	IDDHALT(2)		Internal PLL oscillation stopped Internal RC oscillation stopped USB circuit stopped 1/1 frequency division ratio	3.0 to 3.6		2.7	6.4	
	IDDHALT(3)		HALT mode FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side	4.5 to 5.5		9.5	23	
	IDDHALT(4)		Internal PLL oscillation mode active Internal RC oscillation stopped USB circuit active I/1 frequency division ratio	3.0 to 3.6		4.7	12	mA
	IDDHALT(5)		HALT mode FmCF=12MHz ceramic oscillation mode	4.5 to 5.5		3.0	7.3	
	IDDHALT(6)		FsX'tal=32.768kHz crystal oscillation mode System clock set to 6MHz side	3.0 to 3.6		1.6	3.8	
	IDDHALT(7)					1.3	2.9	-
							-	
	IDDHALT(8)		HALT mode FmCF (Ulz(equillation atomacd))	4.5 to 5.5		0.41	2.0	
	IDDHALT(8)		HALT mode FmCF=0Hz(oscillation stopped) FsX'tal=32.768kHz crystal oscillation mode System clock set to internal RC oscillation.	4.5 to 5.5 3.0 to 3.6		0.41	2.0 0.95	

Note 7-1: The consumption current value includes none of the currents that flow into the output Tr and internal pull-up resistors.

Continued on next page.

Continued from preceding page.

Parameter	Cumbal	Pin/	Conditions			Specif	ication	
Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
HALT mode consumption	IDDHALT(11)	V _{DD} 1 =V _{DD} 2	HALT mode FmCF=0MHz (oscillation stopped)	4.5 to 5.5		31	132	mA
current (Note 7-1)	IDDHALT(12)	=V _{DD} 3	FsX'tal=32.768kHz crystal oscillation mode System clock set to crystal oscillation.	3.0 to 3.6		9.1	39	
	IDDHALT(13)		(32.768kHz) Internal RC oscillation stopped 1/2 frequency division ratio	2.7 to 3.0		6.3	27	
HOLD mode	IDDHOLD(1)	V _{DD} 1	HOLD mode	4.5 to 5.5		0.14	39	
consumption	IDDHOLD(2)		CF1=V _{DD} or open (External clock mode)	3.0 to 3.6		0.04	19	μΑ
current	IDDHOLD(3)			2.7 to 3.0		0.04	17	
Timer HOLD	IDDHOLD(4)		Timer HOLD mode	4.5 to 5.5		25	115	
mode	IDDHOLD(5)		CF1=V _{DD} or open (External clock mode)	3.0 to 3.6		6.0	32	
consumption current	IDDHOLD(6)		FsX'tal=32.768kHz crystal oscillation mode	2.7 to 3.0		3.7	20	

Note 7-1: The consumption current value includes none of the currents that flow into the output Tr and internal pull-up resistors

USB Characteristics and Timing at Ta = -40°C to +85°C, $V_SS1 = V_SS2 = V_SS3 = 0V$

		10 0 10 100 0, 1001	- 00-	, 222	0 1	
Parameter	Symbol	Conditions		Specifi	cation	
Falametei	Symbol	Conditions	min	typ	max	unit
High level output	VOH(USB)	• 15kΩ±5% to GND	2.8		3.6	>
Low level output	V _{OL(USB)}	• 1.5kΩ±5% to 3.6V	0.0		0.3	٧
Output signal crossover voltage	VCRS		1.3		2.0	٧
Differential input sensitivity	V _{DI}	• (UHD+)-(UHD-)	0.2			٧
Differential input common mode range	V _{CM}		0.8		2.5	٧
High level input	VIH(USB)		2.0			٧
Low level input	V _{IL} (USB)				0.8	٧
USB data rise time	t _R	• R _S =33Ω, C _L =50pF	4		20	ns
USB data fall time	tF	• R _S =33Ω, C _L =50pF	4		20	ns

F-ROM Programming Characteristics at $Ta = +10^{\circ}C$ to $+55^{\circ}C$, $V_{SS}1 = 0V$

	_									
Parameter	Cumbal	Pin/	Conditions		Specification					
Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit		
Onboard programming current	IDDFW(1)	V _{DD} 1	Excluding power dissipation in the microcontroller block	3.0 to 5.5		5	10	mA		
Programming time	tFW(1)		Erase operation	3.0 to 5.5		20	30	ms		
	tFW(2)		Write operation	3.0 10 5.5		40	60	μs		

Characteristics of a Sample Main System Clock Oscillation Circuit

Given below are the characteristics of a sample main system clock oscillation circuit that are measured using a SANYO-designated oscillation characteristics evaluation board and external components with circuit constant values with which the oscillator vendor confirmed normal and stable oscillation.

Table 1 shows the characteristics of a oscillation circuit when USB host function is not used.

If USB host function is to be used, it is absolutely recommended to use an oscillator that satisfies the precision and stability according to the USB standards.

Nominal Vendor Frequency Name	Oscillator Name	Circuit Constant			Operating Voltage	Oscillation Stabilization Time			
		C1 [pF]	C2 [pF]	Rd1 [Ω]	Range [V]	typ [ms]	max [ms]	Remarks	
6MHz	MURATA	CSTCR6M00GH5L**-R0	(39)	(39)	1k	2.7 to 5.5	0.1	0.5	C1 and C2 integrated SMD type
8MHz	MURATA	CSTCE8M00GH5L**-R0	(33)	(33)	470	3.0 to 5.5	0.1	0.5	
10MHz	MURATA	CSTCE10M0GH5L**-R0	(33)	(33)	330	3.0 to 5.5	0.1	0.5	
12MHz	MURATA	CSTCE12M0GH5L**-R0	(33)	(33)	330	3.0 to 5.5	0.1	0.5	

The oscillation stabilization time refers to the time interval that is required for the oscillation to get stabilized in the following cases (see Figure 4):

- Till the oscillation gets stabilized after VDD goes above the operating voltage lower limit.
- Till the oscillation gets stabilized after the instruction for starting the main clock oscillation circuit is executed
- Till the oscillation gets stabilized after the HOLD mode is reset.
- Till the oscillation gets stabilized after the X'tal HOLD mode is reset with CFSTOP (OCR register, bit 0) set to 0

Characteristics of a Sample Subsystem Clock Oscillator Circuit

Given below are the characteristics of a sample subsystem clock oscillation circuit that are measured using a SANYO-designated oscillation characteristics evaluation board and external components with circuit constant values with which the oscillator vendor confirmed normal and stable oscillation.

Table 2 Characteristics of a Sample Subsystem Clock Oscillator Circuit with a Crystal Oscillator

Nominal Vendor Frequency Name	Vendor		Circuit Constant				Operating Voltage	Oscillation Stabilization Time		
	Oscillator Name	C3	C4	Rf	Rd2	Range	Range typ max		Remarks	
			[pF]	[pF]	$[\Omega]$	$[\Omega]$	[V]	[s]	[s]	
	EPSON									Applicable
32.768kHz	TOYOCOM	MC-306	18	18	OPEN	560k	2.7 to 5.5	1.1	3.0	CL value=12.5pF
	101000111									SMD type

The oscillation stabilization time refers to the time interval that is required for the oscillation to get stabilized in the following cases (see Figure 4):

- Till the oscillation gets stabilized after the instruction for starting the subclock oscillation circuit is executed
- Till the oscillation gets stabilized after the HOLD mode is reset with EXTOSC (OCR register, bit 6) set to 1

Note: The components that are involved in oscillation should be placed as close to the IC and to one another as possible because they are vulnerable to the influences of the circuit pattern.

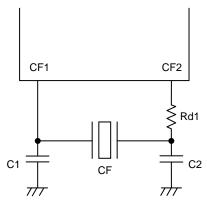


Figure 1 CF Oscillator Circuit

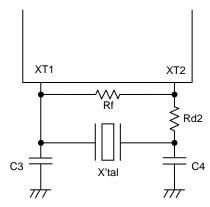


Figure 2 Crystal Oscillator Circuit

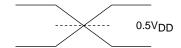
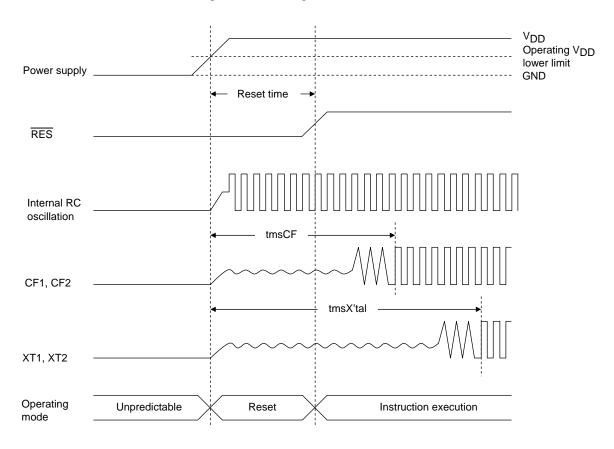
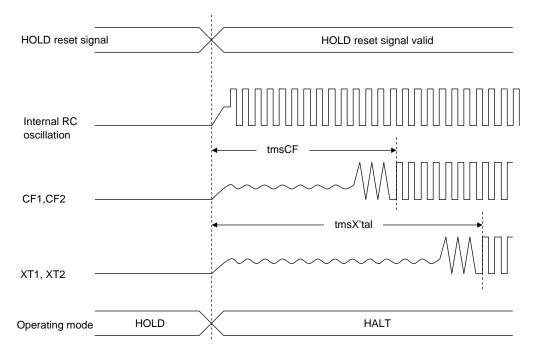


Figure 3 AC Timing Measurement Point

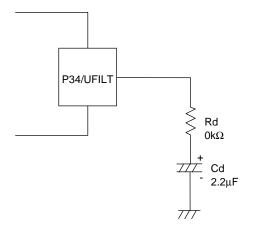


Reset Time and Oscillation Stabilization Time



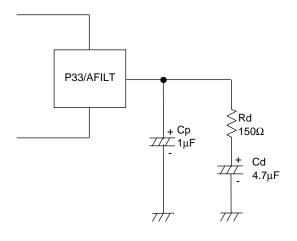
HOLD Reset Signal and Oscillation Stabilization Time

Figure 4 Oscillation Stabilization Time



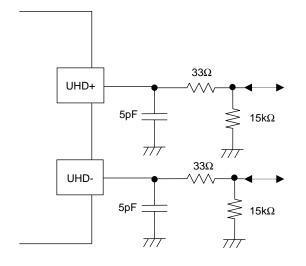
When using the internal PLL circuit to generate the 48MHz clock for USB , it is necessary to connect a filter circuit such to the P34/UFILT pin such as that shown in the left Fig.

Figure 5 External Filter Circuit for the Internal USB-dedicated PLL Circuit



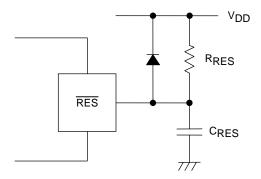
To generate the master clock for the audio interface using the internal PLL circuit, it is necessary to connect a filter circuit to the P33/AFILT pin that is shown in the left Fig.

Figure 6 External Filter Circuit for Audio Interface (Used with Internal PLL Circuit)



It's necessary to adjust the Circuit Constant of the USB Port Peripheral Circuit for each mounting board.

Figure 7 USB Port Peripheral Circuit



Note:

Determine the value of CRES and RRES so that the reset signal is present for a period of 200µs after the supply voltage goes beyond the lower limit of the IC's operating voltage.

Figure 8 Reset Circuit

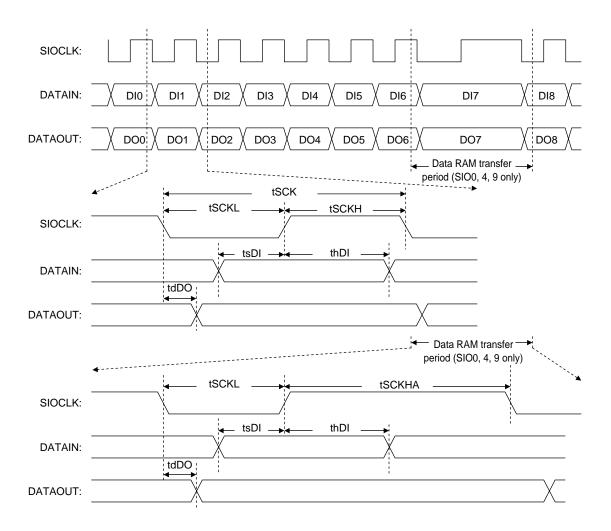


Figure 9 Serial Input/Output Waveform

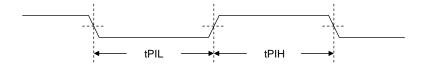


Figure 10 Pulse Input Timing Signal Waveform

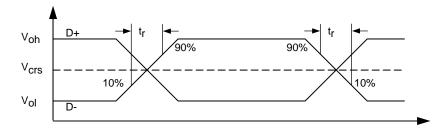
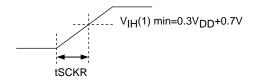


Figure 11 USB Data Signal Timing and Voltage Level



tSCKR:

Defined as the time period from the time the state of the output starts changing till the time it reaches the minimum value of $V_{IH}(1)$.

Figure 12 Serial Clock Output Timing Signal Waveform

- SANYO Semiconductor Co.,Ltd. assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all SANYO Semiconductor Co.,Ltd. products described or contained herein.
- SANYO Semiconductor Co.,Ltd. strives to supply high-quality high-reliability products, however, any and all semiconductor products fail or malfunction with some probability. It is possible that these probabilistic failures or malfunction could give rise to accidents or events that could endanger human lives, trouble that could give rise to smoke or fire, or accidents that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all SANYO Semiconductor Co.,Ltd. products described or contained herein are controlled under any of applicable local export control laws and regulations, such products may require the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written consent of SANYO Semiconductor Co.,Ltd.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the SANYO Semiconductor Co.,Ltd. product that you intend to use.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production.
- Upon using the technical information or products described herein, neither warranty nor license shall be granted with regard to intellectual property rights or any other rights of SANYO Semiconductor Co.,Ltd. or any third party. SANYO Semiconductor Co.,Ltd. shall not be liable for any claim or suits with regard to a third party's intellectual property rights which has resulted from the use of the technical information and products mentioned above.

This catalog provides information as of December, 2008. Specifications and information herein are subject to change without notice.